L Number	Hits	Search Text	DB	Time stamp
1	850	"I4" and 714/(736-738).ccls. and (location	USPAT;	2004/01/22
		with vector) and compare	US-PGPUB;	07:07
			EPO; JPO;	
			DERWENT;	
			IBM_TDB	
2	61534	(fault error short) and ((integrated adj	USPAT;	2004/01/22
		circuit) or IC or chip or wafer) and (vector	US-PGPUB;	07:07
I		signal pattern) and compare	EPO; JPO;	
			DERWENT;	
			IBM_TDB	
3	165744	(fault error short) and ((integrated adj	USPAT;	2004/01/22
		circuit) or IC or chip or wafer) and (vector	US-PGPUB;	07:08
		signal pattern) and (compare compared	EPO; JPO;	
		comparing comparison)	DERWENT;	
			IBM_TDB	
4	78	(fault error short) and ((integrated adj	USPAT;	2004/01/22
		circuit) or IC or chip or wafer) and (vector	US-PGPUB;	10:07
		signal pattern) and (compare compared	EPO; JPO;	
		comparing comparison) and 714/819.ccls.	DERWENT;	
			IBM_TDB	
5	24945	(fault error short) and ((integrated adj	USPAT;	2004/01/22
		circuit) or IC or chip or wafer) and (vector	US-PGPUB;	10:07
		signal pattern) and (compare compared	EPO; JPO;	
		comparing comparison) and	DERWENT;	
		324/(522-523).ccls.	IBM_TDB	
6	24945	(fault error short) and ((integrated adj	USPAT;	2004/01/22
		circuit) or IC or chip or wafer) and (vector	US-PGPUB;	10:10
		signal pattern) and (compare compared	EPO; JPO;	
		comparing comparison) and	DERWENT;	
		324/(522-523).ccls. and (NRZ or (return near2 zero))	IBM_TDB	
7	325379	324/(522-523).ccls. and (NRZ or (return	USPAT;	2004/01/22
		near2 zero))	US-PGPUB;	10:09
		,	EPO; JPO;	
			DERWENT;	
			IBM_TDB	
9	O	324/523.ccls. and (NRZ or (return near2	USPAT;	2004/01/22
		zero))	US-PGPUB;	10:10
			EPO; JPO;	
			DERWENT;	
			IBM_TDB	
10	1	(fault error short) and ((integrated adj	USPAT;	2004/01/22
		circuit) or IC or chip or wafer) and (vector	US-PGPUB;	10:10
		signal pattern) and (compare compared	EPO; JPO;	
		comparing comparison) and 324/522.ccls.	DERWENT;	
		and (NRZ or (return near2 zero))	IBM_TDB	
8	5	324/522.ccls. and (NRZ or (return near2	USPAT;	2004/01/22
		zero))	US-PGPUB;	10:11
			EPO; JPO;	
			DERWENT;	
			IBM_TDB	

20	5	4309657.URPN.	USPAT	2004/01/22	٦
				13:40	
•	2	6526546.pn.	USPAT;	2004/01/21	-
			US-PGPUB;	17:48	
			EPO; JPO;	:	
			DERWENT;		
			IBM_TDB		
-	82	desplats.in.	USPAT;	2004/01/21	
			US-PGPUB;	15:30	١
			EPO; JPO;		
			DERWENT;		
			IBM_TDB		ı
•	9	desplats.in. and perdu.in.	USPAT;	2004/01/21	
			US-PGPUB;	15:30	
			EPO; JPO;		
			DERWENT;		
			IBM_TDB		

			_	
103	("5274264"		USPAT;	2004/01/21
	"5375126"		US-PGPUB;	17:49
	"5481548"		EPO; JPO;	
	"5498964"		DERWENT;	
	"5528748"		IBM_TDB	
	"5600788"			
	"5696451"			
	"6070252"			
	"4309657"			
	"4395767"			
	"4487121"			
	"4820991"			
	"4872168"			
	"4967151"	į		
	"5222066"			
	"5299136"			
	"5406565"			
	"5425035"			
	"5537632"			
	"5570376"			
	"5668815"			
	"5673028"			
	"5696788"			
	"5862151"			
	"5892539"			
	"5982681"			
	"6041390"			
	"6096093"			
	"4625310"			
	"4871257"			
	"6219808"			
	"6219808"			
	"6239604"			
	"4862399"			
	"5276400"			
	"5420522"			
	"5422891"			
	"5465053"			
	"5515383"			
	"5633812"			
	"5726997"			
	"6148425"			
	"4423509"			
	"4438494"			
	"4463450"			
	"4481627"			
	"4542509"			
	"4554661"			
	"4556840"			
	"4594711").pn.			

	49	("5274264"	USPAT;	2004/01/21
	43	"5375126"	US-PGPUB	18:04
		"5481548"		.010-7
		"5498964"		
		"5528748"		
		"5600788"		
		"5696451"		
		"6070252"		
		"4309657"		
		"4395767"		
		"4487121"		
		"4820991"		
		"4872168"		
		"4967151"		
		"5222066"		
		"5299136"		
		"5406565"		
		"5425035"		
		"5537632"		
		"5570376"		
		"5668815"		
		"5673028"		
		"5696788"		
		"5862151"		
		"5892539"		
		"5982681"		
		"6041390"		
		"6096093"		
		"4625310"		
		"4871257"		
-		"6219808"		
		"6219808"		
		"6239604"		
		"4862399"		
		"5276400"		
		"5420522"		
		"5422891"	1	
		"5465053"		
		"5515383"		
		"5633812"		
		"5726997"		
		"6148425"		
		"4423509"		
		"4438494"		
		"4463450"		
		"4481627"		
		"4481627" "4542509"	1	
		"454661"		
		"4556840"	1	
		"4594711").pn.	1	
		-voorti j.pn.		
	<u>L</u>	<u> </u>	1 .	I

			T	
-	327102	(fault error short) and ((integrated adj	USPAT;	2004/01/21
		circuit) or IC or chip or wafer)	US-PGPUB;	18:06
			EPO; JPO;	
			DERWENT;	
			IBM_TDB	
-	251560	(fault error short) and ((integrated adj	USPAT;	2004/01/21
		circuit) or IC or chip or wafer) and (vector	US-PGPUB;	19:10
		signal pattern)	EPO; JPO;	
			DERWENT;	
			IBM_TDB	
-	99370	(fault error short) and ((integrated adj	USPAT;	2004/01/21
		circuit) or IC or chip or wafer) and (vector	US-PGPUB;	19:31
		signal pattern) and sequence	EPO; JPO;	
			DERWENT;	
			IBM_TDB	
-	121	(fault error short) and ((integrated adj	USPAT;	2004/01/21
		circuit) or IC or chip or wafer) and (vector	US-PGPUB;	18:20
		signal pattern) and sequence and IDDQ	EPO; JPO;	
			DERWENT;	
			IBM_TDB	
-	124	(fault error short) and ((integrated adj	USPAT;	2004/01/21
		circuit) or IC or chip or wafer or circuit) and	US-PGPUB;	18:21
		(vector signal pattern) and sequence and	EPO; JPO;	
		IDDQ	DERWENT;	
			IBM_TDB	
-	853	location adj vector	USPAT;	2004/01/21
			US-PGPUB;	19:11
			EPO; JPO;	
			DERWENT;	
			IBM_TDB	
-	186	IDDQ with (measure monitor measured	USPAT;	2004/01/21
		measuring monitored monitoring)	US-PGPUB;	19:12
			EPO; JPO;	
			DERWENT;	
			IBM_TDB	
-	12586	location with vector	USPAT;	2004/01/21
			US-PGPUB;	19:11
			EPO; JPO;	
			DERWENT;	
			IBM_TDB	
-	2	(IDDQ with (measure monitor measured	USPAT;	2004/01/21
		measuring monitored monitoring)) and	US-PGPUB;	19:11
		(location with vector)	EPO; JPO;	
			DERWENT;	
			IBM_TDB	
-	232	IDDQ with (measure monitor measured	USPAT;	2004/01/21
		measuring monitored value monitoring)	US-PGPUB;	19:12
1		· · · · · · · · · · · · · · · · · · ·	EPO; JPO;	
			DERWENT;	
•				

•	6	(IDDQ with (measure monitor measured	USPAT;	2004/01/21
		measuring monitored value monitoring))	US-PGPUB;	19:25
		and (location with vector)	EPO; JPO;	
			DERWENT;	
			IBM_TDB	
-	21252	((fault error short) and ((integrated adj	USPAT;	2004/01/21
		circuit) or IC or chip or wafer)) and	US-PGPUB;	19:26
		714/(736-738).ccls.	EPO; JPO;	
			DERWENT;	
			IBM_TDB	
-	19854	((fault error short) and ((integrated adj	USPAT;	2004/01/21
		circuit) or IC or chip or wafer) and (vector	US-PGPUB;	19:29
		signal pattern)) and 714/(736-738).ccls.	EPO; JPO;	
			DERWENT;	
			IBM_TDB	
-	19854	((fault error short) and ((integrated adj	USPAT;	2004/01/21
		circuit) or IC or chip or wafer) and (vector	US-PGPUB;	19:30
		signal pattern)) and 714/(736-738).ccls. and	EPO; JPO;	
		(location with vector)	DERWENT;	
			IBM_TDB	